

**IPC-A-610**

**Revision J – March 2024**

**Supersedes Revision H**

**September 2020**

# Acceptability of Electronic Assemblies



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Developed by



BUILD ELECTRONICS BETTER

participants from  
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**IPC-A-610J**

# Acceptability of Electronic Assemblies

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Developed by the IPC-A-610 Task Group (7-31b), IPC-A-610 Task Group – Europe (7-31b-EU) and IPC-A-610 Task Group – China (7-31b-CN) of the Product Assurance Committee (7-30) of IPC

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# 1.0 General

**1.1 Scope** This standard is a collection of visual quality acceptability requirements for electronic assemblies. This standard does not provide criteria for cross-section evaluation or x-ray inspection. There are x-ray guidelines located in J-STD-001.

This document presents acceptance requirements for the manufacture of electrical and electronic assemblies. Historically, electronic assembly standards contained a more comprehensive tutorial addressing principles and techniques. For a more complete understanding of this document's recommendations and requirements, one may use this document in conjunction with IPC-HDBK-001 or IPC-AJ-820.

The criteria in this standard are not intended to define processes to accomplish assembly operations nor is it intended to authorize repair/modification or change of the product. For instance, the presence of criteria for adhesive bonding of components does not imply/authorize/require the use of adhesive bonding and the depiction of a leads/conductors wrapped clockwise around a terminal does not imply/authorize/require that all leads/conductors be wrapped in the clockwise direction.

Users of this standard should be knowledgeable of the applicable requirements of the document and how to apply them, see 1.3 Classification.

IPC-A-610 has criteria outside the scope of J-STD-001 defining mechanical and other workmanship requirements. Table 1-1 is a summary of related IPC documents that the user may want to be familiar with to better understand the requirements of this document. For additional referenced documents see section 2.0 Applicable Documents.

**Table 1-1 Summary of Related Documents**

Document Purpose	Spec.#	Definition
Design Standard	IPC-222X IPC-7351 IPC-CM-770	Design requirements reflecting three levels of complexity (Levels A, B, and C) indicating finer geometries, greater densities, more process steps to produce the product.  Component and Assembly Process Guidelines to assist in the design of the bare board and the assembly where the bare board processes concentrate on land patterns for surface mount and the assembly concentrates on surface mount and through-hole principles which are usually incorporated into the design process and the documentation.
Printed Board – Requirements	IPC-601X IPC-A-600	Requirements and acceptance documentation for rigid, rigid flex, flex and other types of substrates.
Process Requirement Standard	J-STD-001	Requirements for soldered electrical and electronic assemblies depicting minimum end product acceptable characteristics as well as methods for evaluation (test methods), frequency of testing and applicable ability of process control requirements.
Acceptability Standard	IPC-A-610	Pictorial interpretive document indicating various characteristics of the board and/or assembly as appropriate relating to desirable conditions that exceed the minimum acceptable characteristics indicated by the end item performance standard and reflect various out-of-control (process indicator or defect) conditions to assist the shop process evaluators in judging need for corrective action.
Training Programs (Optional)		Documented training for process, procedures, techniques and requirements.
Rework and Repair	IPC-7711/7721	Documentation providing the procedures to accomplish conformal coating and component removal and replacement, solder resist repair, and modification/repair of laminate material, conductors, and PTHs (plated through-holes).
Assembly and Joining Handbook	IPC-AJ-820	IPC-AJ-820 is a supporting document that provides information regarding the intent of this specification content and explains or amplifies the technical rationale for transition of limits through Acceptable to Defect condition criteria. In addition, supporting information is provided to give a broader understanding of the process considerations that are related to performance but not commonly distinguishable through visual assessment methods  The explanations provided in IPC-AJ-820 should be useful in determining disposition of conditions identified as Defect, processes associated with Process Indicators, as well as answering questions regarding clarification in use and application for defined content of this specification. Contractual reference to IPC-A-610 does not additionally impose the content of IPC-AJ-820 unless specifically referenced in contractual documentation.

**1.2 Purpose** The visual standards in this document reflect the requirements of existing IPC and other applicable specifications. For the content of this document to apply, the assembly/product should comply with other existing IPC requirements, such as IPC-7351, IPC-222X (where X is the last digit in the IPC document number), IPC-601X and IPC-A-600. If the assembly does not comply with these or with equivalent requirements, the acceptance criteria **shall** be defined between the User and Supplier.